

FSTU3257

Quad 2:1 Multiplexer/Demultiplexer Bus Switch with –2V Undershoot Protection

General Description

The Fairchild Switch FSTU3257 is a quad 2:1 high-speed CMOS TTL-compatible multiplexer/demultiplexer bus switch. The low on resistance of the switch allows inputs to be connected to outputs without adding propagation delay or generating additional ground bounce noise.

When $\overline{OE}$ is LOW, the select pin connects the A Port to the selected B Port output. The A and B Ports are "undershoot hardened" with Undershoot Hardened Circuit (UHC®™) protection to support an extended range of 2.0V below ground. Fairchild's integrated UHC senses undershoot at the I/O and responds by preventing voltage differentials from developing and turning on the switch. When $\overline{OE}$ is HIGH, the switch is OPEN and a high-impedance state exists between the two ports.

Features

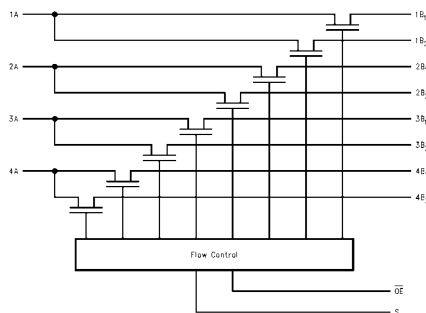
- Undershoot hardened to –2V (A and B Ports)
- Soft enable turn-on to minimize bus to bus charge sharing during enable
- 4Ω switch connection between two ports.
- Minimal propagation delay through the switch.
- Low I_{CC} .
- Zero bounce in flow-through mode.
- Control inputs compatible with TTL level.
- See Applications Note AN-5008 for details

Ordering Code:

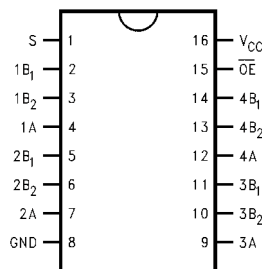
Order Number	Package Number	Package Description
FSTU3257M	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
FSTU3257QSC	MQA16	16-Lead Quarter Size Outline Package (QSOP), JEDEC MO-137, 0.150" Wide
FSTU3257MTC	MTC16	16-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

Logic Diagram



Connection Diagram



Pin Descriptions

Pin Name	Description
$\overline{OE}$	Bus Switch Enable
S	Select Input
A	Bus A
B ₁ –B ₂	Bus B

Truth Table

S	$\overline{OE}$	Function
X	H	Disconnect
L	L	A = B ₁
H	L	A = B ₂

UHC®™ is a registered trademark of Fairchild Semiconductor Corporation.

Absolute Maximum Ratings(Note 1)

Supply Voltage (V_{CC})	–0.5V to +7.0V
DC Switch Voltage (V_S) (Note 2)	–2.0V to +7.0V
DC Input Control Pin Voltage (V_{IN})(Note 3)	–0.5V to +7.0V
DC Input Diode Current (I_{IK}) $V_{IN} < 0V$	–50mA
DC Output (I_{OUT})	128mA
DC V_{CC} /GND Current (I_{CC}/I_{GND})	+/- 100mA
Storage Temperature Range (T_{STG})	–65°C to +150 °C
ESD	
Human Body Model	5kV

Recommended Operating Conditions (Note 4)

Power Supply Operating (V_{CC})	4.0V to 5.5V
Input Voltage (V_{IN})	0V to 5.5V
Output Voltage (V_{OUT})	0V to 5.5V
Input Rise and Fall Time (t_r , t_f)	
Switch Control Input	0nS/V to 5nS/V
Switch I/O	0nS/V to DC
Free Air Operating Temperature (T_A)	–40 °C to +85 °C

Note 1: The Absolute Maximum Ratings are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum rating. The Recommended Operating Conditions tables will define the conditions for actual device operation.

Note 2: V_S is the voltage observed/applied at either the A or B Ports across the switch.

Note 3: The input and output negative voltage ratings may be exceeded if the input and output diode current ratings are observed.

Note 4: Unused control inputs must be held HIGH or LOW. They may not float.

DC Electrical Characteristics

Symbol	Parameter	V_{CC} (V)	$T_A = -40\text{ °C to }+85\text{ °C}$			Units	Conditions
			Min	Typ (Note 5)	Max		
V_{IK}	Clamp Diode Voltage	4.5			–1.2	V	$I_{IN} = -18mA$
V_{IH}	HIGH Level Input Voltage	4.0–5.5	2.0			V	
V_{IL}	LOW Level Input Voltage	4.0–5.5			0.8	V	
I_I	Input Leakage Current	5.5			±1.0	µA	$0 \leq V_{IN} \leq 5.5V$
I_{OZ}	OFF-STATE Leakage Current	5.5			±1.0	µA	$0 \leq A, B \leq V_{CC}$
R_{ON}	Switch On Resistance (Note 6)	4.5		4	7	Ω	$V_{IN} = 0V, I_{IN} = 64mA$
		4.5		4	7	Ω	$V_{IN} = 0V, I_{IN} = 30mA$
		4.5		8	15	Ω	$V_{IN} = 2.4V, I_{IN} = 15mA$
		4.0		11	20	Ω	$V_{IN} = 2.4V, I_{IN} = 15mA$
I_{CC}	Quiescent Supply Current	5.5			3	µA	$V_{IN} = V_{CC}$ or GND, $I_{OUT} = 0$
ΔI_{CC}	Increase in I_{CC} per Input	5.5			2.5	mA	One input at 3.4V Other inputs at V_{CC} or GND
V_{IKU}	Voltage Undershoot	5.5			–2.0	V	$0.0mA \geq I_{IN} \geq -50mA$ $\overline{OE} = 5.5V$

Note 5: Typical values are at $V_{CC} = 5.0V$ and $T_A = +25^\circ C$

Note 6: Measured by the voltage drop between A and B pins at the indicated current through the switch. On resistance is determined by the lower of the voltages on the two (A or B) pins.

AC Electrical Characteristics

Symbol	Parameter	T _A = −40 °C to +85 °C, C _L = 50pF, R _U = R _D = 500Ω				Units	Conditions	Figure No.
		V _{CC} = 4.5 – 5.5V		V _{CC} = 4.0V				
		Min	Max	Min	Max			
t _{PHL} , t _{PLH}	Prop Delay Bus to Bus (Note 7)		0.25		0.25	ns	V _I = OPEN	Figures 2, 3
	Prop Delay, Select to Bus A	7.0	30.0		35.0			
t _{PZH} , t _{PZL}	Output Enable Time, Select to Bus B	7.0	30.0		35.0	ns	V _I = 7V for t _{pZL}	Figures 2, 3
	Output Enable Time, OE to Bus A, B	7.0	30.0		35.0		V _I = OPEN for t _{pZH}	
t _{PHZ} , t _{PLZ}	Output Disable Time, Select to Bus B	1.5	8.4		9.8	ns	V _I = 7V for t _{pLZ}	Figures 2, 3
	Output Disable Time, Output Enable Time, OE to Bus A, B	1.5	8.8		9.8		V _I = OPEN for t _{pHZ}	

Note 7: This parameter is guaranteed by design but is not tested. The bus switch contributes no propagation delay other than the RC delay of the typical On resistance of the switch and the 50pF load capacitance, when driven by an ideal voltage the source (zero output impedance).

Capacitance (Note 8)

Symbol	Parameter	Typ	Max	Units	Conditions
C_{IN}	Control Pin Input Capacitance	3		pF	$V_{CC} = 5.0\text{V}$
$C_{I/O}$	Input/Output Capacitance	7.5		pF	$V_{CC}, \overline{\text{OE}} = 5.0\text{V}$
		5.5		pF	
$C_{I/O \text{ ON State}}$	Input/Output Capacitance ON State (A or B Port)	14		pF	$V_{CC} = 5.0\text{V}$ Switch ON

Note 8: $T_A = +25^\circ\text{C}$, $f = 1\text{ MHz}$, Capacitance is characterized but not tested.

Undershoot Characteristic (Note 9)

Symbol	Parameter	Min	Typ	Max	Units	Conditions
V_{OUTU}	Output Voltage During Undershoot	2.5	$V_{OH} - 0.3$		V	Figure 1

Note 9: This is intended to characterize the device's protective capabilities by maintaining output signal integrity during an input transient voltage undershoot event.

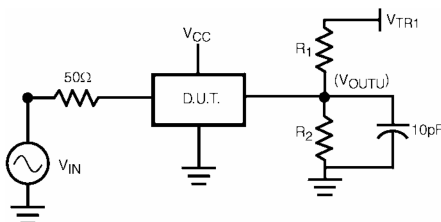
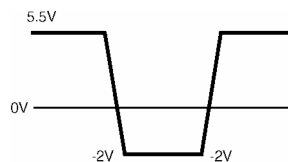


FIGURE 1.

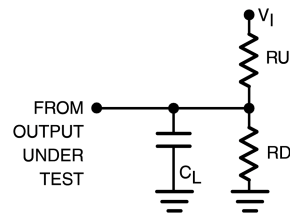
Device Test Conditions

Parameter	Value	Units
V_{IN}	See Waveform	V
$R_1 - R_2$	100K	Ω
V_{TRI}	11.0	V
V_{CC}	5.5	V

Transient Input Voltage (V_{IN}) Waveform



AC Loading and Waveforms



Note: Input driven by 50Ω source terminated in 50Ω

Note: C_L includes load and stray capacitance

Note: Input PRR = 1.0 MHz, $t_W = 500$ ns

FIGURE 2. AC Test Circuit

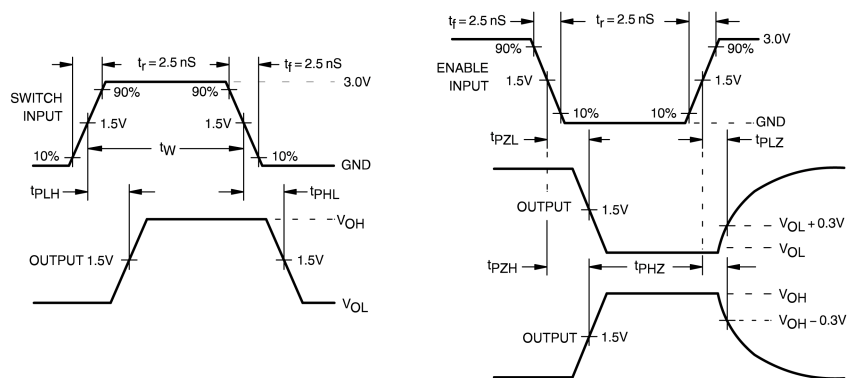
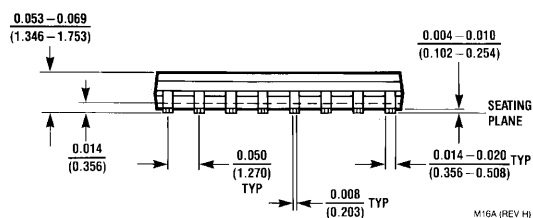
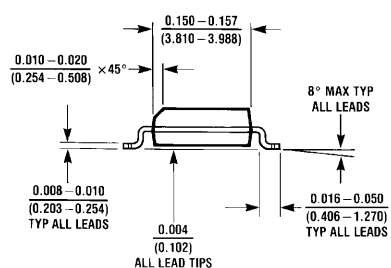
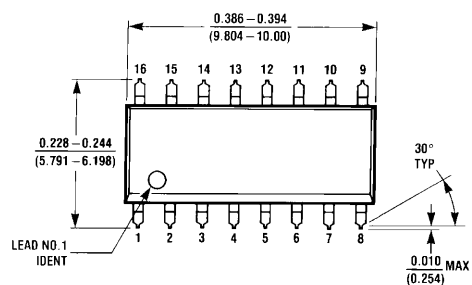


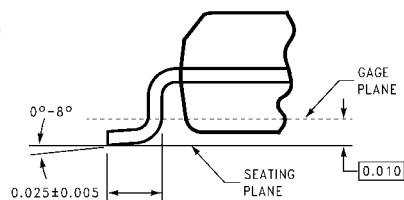
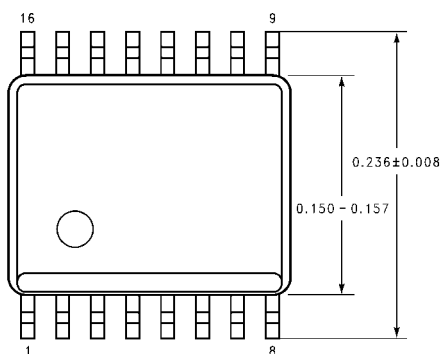
FIGURE 3. AC Waveforms

Physical Dimensions inches (millimeters) unless otherwise noted

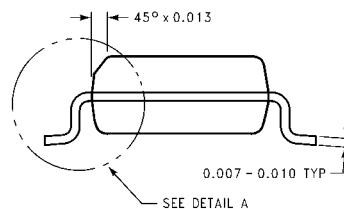
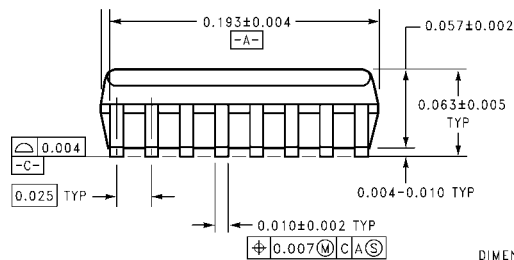


M16A (REV H)

**16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
Package Number M16A**



DETAIL A
TYPICAL, SCALE: 40%

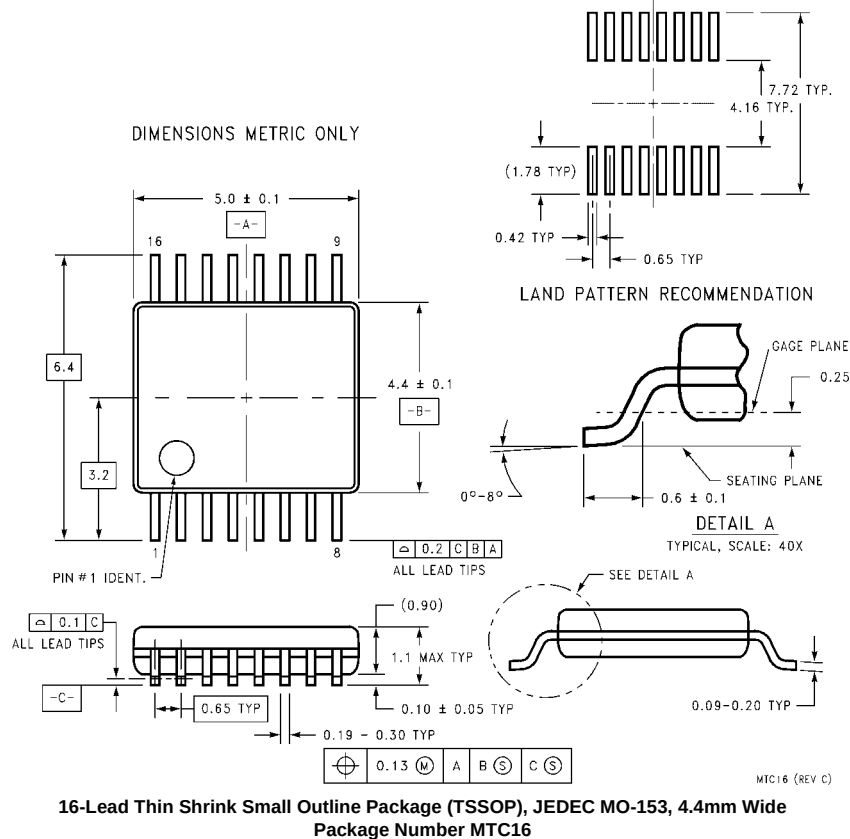


DIMENSIONS ARE IN INCHES

MQA16 (REV A)

**16-Lead Quarter Size Outline Package (QSOP), JEDEC MO-137, 0.150" Wide
Package Number MQA16**

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



Technology Description

The Fairchild Switch family derives from and embodies Fairchild's proven switch technology used for several years in its 74LVX3L384 (FST3384) bus switch product.

Fairchild does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and Fairchild reserves the right at any time without notice to change said circuitry and specifications.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

www.fairchildsemi.com